

**Notice of References Cited**

Application/Control No.

10/631,224

Applicant(s)/Patent Under  
Reexamination  
CAO ET AL.

Examiner

Khatol S. Shahnan-Shah

Art Unit

1645

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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	U	O'Connell et al., 23rd Army Science Conference, December 2002.
	V	Letertre et al., Molecular and Cellular Probes, vol.17, pp. 139-147, 2003
	W	Borst et al., Infection and Immunity vol. 61, no. 12, pp. 5421-5425, 1993
	X	sequence alignment # STAENAB for SEQ ID NO:3 and SEQ ID NO: 5.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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